

Notice of References Cited	Application/Control No. 10/788,904		Applicant(s)/Patent Under Reexamination ENRIGHT, JAMES J.	
	Examiner Cang G. Thai		Art Unit 3629	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,797,830	01-1989	Baggarly et al.	705/406
*	B	US-3,819,173	06-1974	Anderson et al.	270/52.04
*	C	US-5,684,706	11-1997	Harman et al.	700/95
*	D	US-5,816,715	10-1998	Harman et al.	400/71
*	E	US-4,384,196	05-1983	McCumber et al.	235/375
*	F	US-3,877,531	04-1975	Storace et al.	177/1
*	G	US-6,064,994	05-2000	Kubatzki et al.	705/410
*	H	US-2004/0064326	04-2004	Vaghi, Nino R.	705/001
*	I	US-5,287,271	02-1994	Rosenbaum, Walter S.	705/8
*	J	US-6,360,001	03-2002	Berger et al.	382/101
*	K	US-5,264,665	11-1993	Delfer, III, Frank W.	177/25.15
*	L	US-2,072,401	03-1937	ERNST KOENIGS; et. al.	546/334
*	M	US-5,060,165	10-1991	Schumacher et al.	700/213

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0 805 421 A2	11-1997	DENMARK	THIEL, WOLFGANG DR	G07 B 17/00
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	John W. Sutherland, "A Quasi-Empirical Mapping of Optimal Scale of Enterprise", October 1980, Management Science (pre-1986), Volume 26, No. 10, ABI/INFORM Global, Page 963.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.